

PCTEST ENGINEERING LABORATORY, INC.

7185 Oakland Mills Road, Columbia, MD 21046 USA Tel. 410.290.6652 / Fax 410.290.6654 http://www.pctestlab.com



HEARING AID COMPATIBILITY

Applicant Name:

LG Electronics MobileComm U.S.A. Inc. 1000 Sylvan Avenue Englewood Cliffs, NJ 07632 United States Date of Testing: 08/08/2016 - 08/10/2016 Test Site/Location: PCTEST Lab, Columbia, MD, USA Test Report Serial No.: 0Y1608121392.ZNF

FCC ID:

ZNFH918

APPLICANT:

LG ELECTRONICS MOBILECOMM U.S.A. INC.

Scope of Test: Application Type: FCC Rule Part(s): HAC Standard: DUT Type: Model(s): Test Device Serial No.: Class II Permissive Change(s): RF Emissions Testing Class II Permissive Change CFR §20.19(b) ANSI C63.19-2011 Portable Handset LG-H918, LGH918, H918, LG-H910PR, LGH910PR, H910PR *Pre-Production Sample* [S/N: 09411] *See FCC Change Document*

C63.19-2011 HAC Category:

M4 (RF EMISSIONS CATEGORY)

This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2011 and has been tested in accordance with the specified measurement procedures. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Randy Ortanez President



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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.



Figure 1-1 Hearing Aid *in-vitu*

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

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2. DUT DESCRIPTION



FCC ID:	ZNFH918
Manufacturer:	LG Electronics MobileComm U.S.A. Inc.
	1000 Sylvan Avenue
	Englewood Cliffs, NJ 07632
	United States
Model(s):	LG-H918, LGH918, H918, LG-H910PR, LGH910PR, H910PR
Serial Number:	09411
Antenna Configurations:	Ant 1 (GSM850, UMTS B5, LTE B5/12/13)
	Ant 2 (GSM1900, UMTS B2/4, LTE B2/4/66)
	Ant 3 (UMTS B5 Diversity, LTE B5/12/13 Diversity)
HAC Test Configurations:	GSM 850, 128, 190, 251, BT Off, WLAN Off, LTE Off
	GSM 1900, 512, 661, 810, BT Off, WLAN Off, LTE Off
DUT Type:	Portable Handset

Simultanoous Voice over Digital Transport Additional GSM Po Band HAC Tested Air-Interface Type Transport (MHz) **But Not Tested OTT Capability** Reduction 850 vo Yes Yes: WIEL or BT N/A No GSM 1900 GPRS/EDG DT No Yes: WIFI or BT Yes No 850 1700 VD No¹ Yes: WIFI or BT N/A N/A UMTS 1900 HSPA DT No Yes: WIFI or BT N/A Yes 700 (B12) 780 (B13) 850 (B5) LTE (FDD) VD³ No^{1 2} Yes: WIFI or BT N/A Yes 1700 (B66) 1700 (B4) 1900 (B2) 2450 5200 No^{1 2} WIFI 5300 VD Yes: GSM, UMTS, or LTE Yes N/A 5500 5800 Yes: GSM, UMTS, or LTE N/A BT 2450 DT No N/A Type Transport Notes: 1. Evaluated for MIE and low-power exemption. VO = Voice Only DT = Digital Data - Not intended for CMRS Service 2. No associated T-coil measurement has been made in accordance with the guidance issued by OET in KDB VD = CMRS and Data Transport publication 285076 D02 T-Coil testing for CMRS IP. 3. The 3GPP VoLTE CMRS service is defined by GSMA in PRD IR.92 for IP Voice Service and Digital Transport.

Table 2-1: ZNFH918 HAC Air Interfaces

I. Power Reduction for WLAN

This device uses an independent fixed level power reduction mechanism for WLAN operations during voice or VoIP held to ear scenarios. Reduced powers were used to evaluate for low-power exemption in Section 9.II for WLAN. Detailed descriptions of the power reduction mechanism are included in the operational description.

II. LTE Band Selection

This device supports the following pairs of LTE bands with similar frequencies: LTE B66 & B4. This pair of LTE bands has the same target power and share the same transmission path. Since the supported frequency spans for the smaller LTE band is completely covered by the larger LTE band, only the larger LTE band (LTE B66) were evaluated for hearing-aid compliance.

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3. ANSI/IEEE C63.19 PERFORMANCE CATEGORIES

I. RF EMISSIONS

The ANSI Standard presents performance requirements for acceptable interoperability of hearing aids with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

Category	Telephone RF Parameters	
Near field Category	E-field emissions CW dB(V/m)	
	f < 960 MHz	
M1	50 to 55	
M2	45 to 50	
M3	40 to 45	
M4	< 40	
f > 960 MHz		
M1	40 to 45	
M2	35 to 40	
M3	30 to 35	
M4	< 30	
Table 3-1WD near-field categories as defined in ANSI C63.19-2011		

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4. SYSTEM SPECIFICATIONS

ER3DV6 E-Field Probe Description

Construction:	One dipole parallel, two dipoles normal to probe axis
Calibration:	Built-in shielding against static charges In air from 100 MHz to 3.0 GHz (absolute accuracy ±6.0%, k=2)
Frequency:	100 MHz to > 6 GHz;
	Linearity: ± 0.2 dB (100 MHz to 3 GHz)
Directivity	± 0.2 dB in air (rotation around probe axis)
	± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	2 V/m to > 1000 V/m
, ,	(M3 or better device readings fall well below diode
	compression point)
Linearity:	± 0.2 dB
Dimensions	Overall length: 330 mm (Tip: 16 mm)
	Tip diameter: 8 mm (Body: 12 mm)
	Distance from probe tip to dipole centers: 2.5 mm

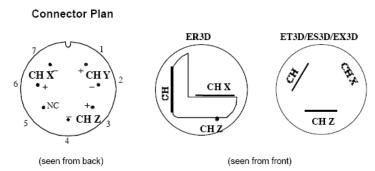


Figure 4-1 E-field Free-space Probe

Probe Tip Description

HAC field measurements take place in the close near field with high gradients. Increasing the measuring distance from the source will generally decrease the measured field values (in case of the validation dipole approx. 10% per mm).

The electric field probes have an irregular internal geometry because it is physically not possible to have the 3 orthogonal sensors situated with the same center. The effect of the different sensor centers is accounted for in the HAC uncertainty budget ("sensor displacement"). Their geometric center is at 2.5mm from the tip, and the element ends are 1.1mm closer to the tip.



The antistatic shielding inside the probe is connected to the probe connector case.

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Instrumentation Chain

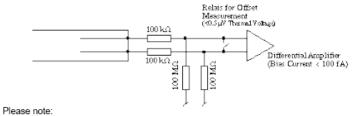
Equation 1 Conversion of Connector Voltage *u_i* to E-Field *E_i*

$$E_i = \sqrt{\frac{u_i + (u_i^2 \cdot CF)/(DCP)}{Norm_i \cdot ConvF}}$$

whereby

Ei:	electric field in V/m
Uj.	voltage of channel i at the connector in μV
Norm	sensitivity of channel i in µV/(V/m) ²
ConvF:	enhancement factor in liquid (ConvF=1 for Air)
DCP:	diode compression point in µV
CF:	signal crest factor (peak power/average power)

Conditions of Calibration



a lower input impedance of the amplifier will result in different sensitivity factors Norm, and DCP

larger bias currents will cause higher offset

Probe Response to Frequency

The E-field sensors have inherently a very flat frequency response. They are calibrated with a number of frequencies resulting in a common calibration factor, with the frequency behavior documented in the calibration certificate (See also below).

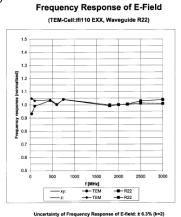


Figure 4-2 E-Field Probe Frequency Response

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SPEAG Robotic System

E-field measurements are performed using the DASY5 automated dosimetric assessment system. The DASY5 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland and consists of high precision robotics system (Staubli), robot controller, Intel CORE i7 computer, near-field probe, probe alignment sensor, and the HAC phantom. The robot is a six-axis industrial robot performing precise movements to position the probe to the location (points) of maximum electromagnetic field (EMF).



Figure 4-3 SPEAG Robotic System

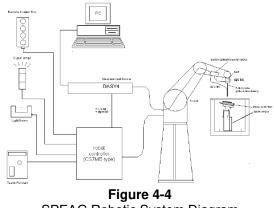
System Hardware

A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and a remote control used to drive the robot motors. The PC consists of the computer with operating system and RF Measurement Software DASY5 v52.8 (with HAC Extension), A/D interface card, monitor, mouse, and keyboard. The Staubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit that performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

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System Electronics

The DAE consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.



SPEAG Robotic System Diagram

DASY5 Instrumentation Chain

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$

with	V_i	= compensated signal of channel i	(i = x, y, z)
	U_i	= input signal of channel i	(i = x, y, z)
	cf	= crest factor of exciting field	(DASY parameter)
	dcp_i	= diode compression point	(DASY parameter)

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From the compensated input signals the primary field data for each channel can be evaluated:

$$\begin{array}{rcl} {\rm E-field probes}: & E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}} \\ \\ {\rm with} & V_i & = {\rm compensated \ signal \ of \ channel \ i} & ({\rm i}={\rm x,\ y,\ z}) \\ & Norm_i & = {\rm sensor \ sensitivity \ of \ channel \ i} & ({\rm i}={\rm x,\ y,\ z}) \\ & \mu {\rm V}/({\rm V/m})^2 \ {\rm for \ E-field \ Probes} \\ & ConvF & = {\rm sensitivity \ enhancement \ in \ solution} \end{array}$$

 E_i = electric field strength of channel i in V/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

The measurement/integration time per point, as specified by the system manufacturer is >500ms.

The signal response time is evaluated as the time required by the system to reach 90% of the expected final value after an on/off switch of the power source with an integration time of 500ms and a probe response time of <5 ms. In the current implementation, DASY5 waits longer than 100ms after having reached the grid point before starting a measurement, i.e., the response time uncertainty is negligible.

If the device under test does not emit a CW signal, the integration time applied to measure the electric field at a specific point may introduce additional uncertainties due to the discretization. The tolerances for the different systems had the worst-case of 2.6%.

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TEST PROCEDURE 5.

Ι. **RF EMISSIONS**

Test Instructions Confirm proper operation of ≻ probes and instrumentation Position WD \geq **Configure WD TX operation** ≻ Per 5.5.1.2 (a-c) Initialize field probe ⋟ ≻ Scan Area Per 5.5.1.2 (d-f) Identify exclusion area. \geq \geq Rescan or reanalyze open area to determine maximum Indirect method: Add the MIF ≻ to the maximum steady state rms field strength and record **RF** Audio Interference Level, in dB(V/m) Per 5.5.1.2 (g-h) & 5.5.1.3 Identify and record the ≻ category

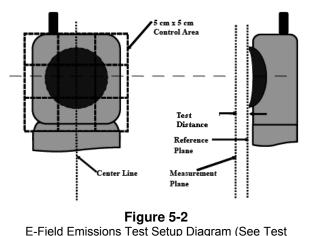
Per 5.5.1.2 (i-j)

Figure 5-1 RF Emissions Flow Chart

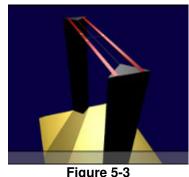
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Test Setup



Photographs for actual WD scan grid overlay)



HAC Phantom

RF Emissions Test Procedure:

The following illustrate a typical RF emissions test scan over a wireless communications device:

- 1. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
- 2. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
- The WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.
- 4. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
- 5. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.
- 6. The measurement system measured the field strength at the reference location.
- 7. Measurements at 2mm or 5mm increments in the 5 x 5 cm region were performed at a distance 15 mm from the center point of the probe measurement element to the WD. A 360° rotation about the azimuth axis at the maximum interpolated position was measured. For the worst-case condition, the peak reading from this rotation was used in re-evaluating the HAC category.
- 8. The system performed a drift evaluation by measuring the field at the reference location. If the power drift deviated by more than 5%, the HAC test and drift measurements were repeated.

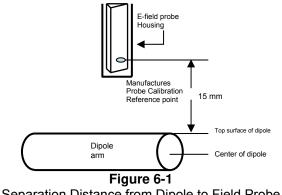
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SYSTEM CHECK 6.

System Check Parameters I.

The input signal was an un-modulated continuous wave. The following points were taken into consideration in performing this check:

- Average Input Power P = 100mW RMS (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion
- The proper measurement of the 15 mm probe to dipole separation, which is measured from top surface of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is shown in the following diagram:



Separation Distance from Dipole to Field Probe

RF power was recorded using both an average reading meter and a peak reading meter. Readings of the probe are provided by the measurement system.

To assure proper operation of the near-field measurement probe the input power to the dipole shall be commensurate with the full rated output power of the wireless device [e.g. - for a cellular phone wireless device the average peak antenna input power will be on the order of 100mW (20dBm) RMS] after adjustment for any mismatch.

II. Validation Procedure

A dipole antenna meeting the requirements given in C63.19 was placed in the position normally occupied by the WD.

The length of the dipole was scanned, and the average peak value was recorded.

Measurement of CW

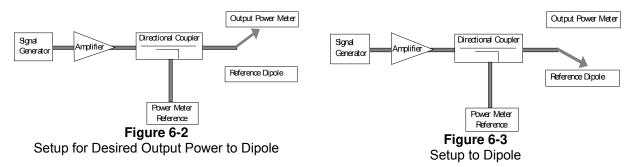
Using the near-field measurement system, scan the antenna over the radiating dipole and record the greatest field reading observed. Due to the nature of E-fields about free-space dipoles, the two E-field peaks measured over the dipole are averaged to compensate for non-parallelity of the setup (see manufacturer method on dipole calibration certificates, page 2). Field strength measurements shall be made only when the probe is stationary.

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RF power was recorded using both an average and a peak power reading meter.



Using this setup configuration, the signal generator was adjusted for the desired output power (100mW) at a specified frequency. The reference power from the coupled port of the directional coupler is recorded. Next, the output cable is connected to the reference dipole, as shown in Figure 6-3.

The input signal level was adjusted until the reference power from the coupled port of the directional coupler was the same as previously recorded, to compensate for the impedance mismatch between the output cable and the reference dipole. To assure proper operation of the near-field measurement probe the input power to the reference dipole was verified to the full rated output power of the wireless device. The dipole was secured in a holder in a manner to meet the 20 dB reflection. The near-field measurement probe was positioned over the dipole. The antenna was scanned over the appropriate sized area to cover the dipole from end to end. SPEAG uses 2D interpolation algorithms between the measured points. Please see below two dimensional plots showing that the interpolated values interpolate smoothly between 5mm steps for a free-space RF dipole:



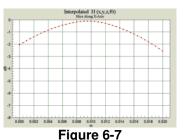
2-D Raw Data from scan along dipole axis



2-D Raw Data from scan along transverse axis



2-D Interpolated points from scan along dipole axis



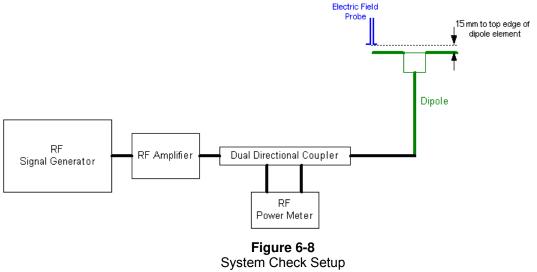
2-D Interpolated points from scan along transverse axis

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III. System Check Results

Validation Results

Frequency (MHz)	Dipole S/N	Input Power (dBm)	E-field Result (V/m)	Target Field (V/m)	% Deviation
835	1082	20.0	110.2	106.8	3.2%
1880	1064	20.0	93.0	89.6	3.8%



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7. MODULATION INTERFERENCE FACTOR

I. Measuring Modulation Interference Factors

For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be determined that relates its interference potential to its steady-state RMS signal level or average power level. This factor is a function only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strength and conducted power measurements. The MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic; any change in modulation characteristic requires determination and application of a new MIF.

The MIF may be determined using a radiated RF field or a conducted RF signal:

- a. Using RF illumination or conducted coupling, apply the specific modulated signal in question to the measurement system at a level within its confirmed operating dynamic range.
- b. Measure the steady-state RMS level at the output of the fast probe or sensor.
- c. Measure the steady-state average level at the weighting output.
- d. Without changing the square-law detector or weighting system, and using RF illumination or conducted coupling, substitute for the specific modulated signal a 1 kHz, 80% amplitude modulated carrier at the same frequency and adjust its strength until the level at the weighting output equals the step c) measurement.
- e. Without changing the carrier level from step d), remove the 1 kHz modulation and again measure the steady-state RMS level indicated at the output of the fast probe or sensor.
- f. The MIF for the specific modulation characteristic is provided by the ratio of the step e) measurement to the step b) measurement, expressed in dB (20 × log[(step e)/(step b)]).

The following procedure was used to measure the MIF using the SPEAG Audio Interference Analyzer (AIA), Type No: SE UMS 170 CB, Serial No.: 1010:

- 1. The device was placed into a simulated call using a base station simulator or set to transmit using test software for a given mode.
- 2. The device was then set to continuously transmit at maximum power.
- 3. Using a coupler if needed, the device output signal was connected to the RF In port of the AIA, which was connected to a desktop computer. Alternatively, a radiated RF signal may be used with the AIA's built-in antenna.
- 4. The MIF measurement procedure in the DASY software was run, and the resulting MIF value was recorded.
- 5. Steps 1-4 were repeated for all CMRS air interfaces, frequency bands, and modulations.

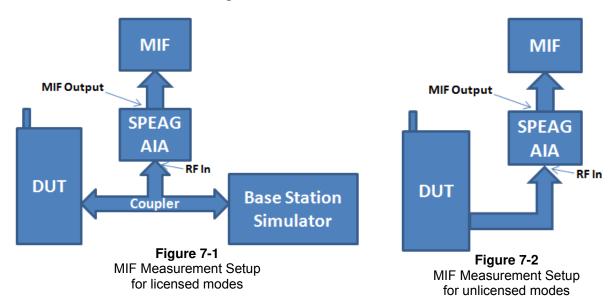
The modulation interference factors obtained were applied to readings taken of the actual wireless device in order to obtain an accurate audio interference level reading using the formula:

Audio Interference Level [dB(V/m)] = 20 * log[Raw Field Value (V/m)] + MIF (dB)

Because the MIF value is output power independent, MIF values for a given mode should be constant across all devices; however, per C63.19-2011 §D.7, MIF values should be measured for each device being evaluated. The voice modes for this device have been investigated in this section of the report.

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II. MIF Measurement Block Diagrams



III. Measured Modulation Interference Factors:

Mode		GSM850		GSM1900		
Mode	128	190	251	512	661	810
GSM	3.51	3.53	3.54	3.54	3.54	3.54

Table 7-1 GSM Modulation Interference Factors¹

Mode		UMTS V			UMTS IV			UMTS II		
		4132	4183	4233	1312	1412	1513	9262	9400	9538
UMTS	12.2 kbps RMC	-23.90	-23.36	-22.97	-24.21	-23.64	-23.54	-24.34	-23.94	-24.15
	12.2 kbps AMR	-12.81	-12.98	-12.83	-12.81	-12.77	-12.77	-12.84	-12.85	-12.97

Table 7-2

UMTS Modulation Interference Factors¹

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

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LTE Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	MIF [dB]
2	1880.0	18900	20	16QAM	1	0	-10.23
5	836.5	20525	10	16QAM	1	0	-10.03
12	707.5	23095	10	16QAM	1	0	-9.78
13	782.0	23230	10	16QAM	1	0	-10.46
66	1745.0	132322	20	16QAM	1	0	-9.96
12	707.5	23095	10	QPSK	1	0	-13.16
12	707.5	23095	10	16QAM	1	25	-9.54
12	707.5	23095	10	16QAM	1	49	-9.67
12	707.5	23095	10	16QAM	25	0	-15.58
12	707.5	23095	10	16QAM	50	0	-16.94
12	707.5	23095	5	16QAM	1	0	-9.42
12	707.5	23095	3	16QAM	1	0	-9.52
12	707.5	23095	1.4	16QAM	1	0	-10.37
12	701.5	23035	5	16QAM	1	0	-9.64
12	713.5	23155	5	16QAM	1	0	-10.59

Table 7-3

LTE FDD Modulation Interference Factors^{1,3}

	802.11b MIF Measurements [dB]							
Mode	Data Rate [Mbps]							
	1	2	5.5	11				
802.11b	-16.91 -16.35 -12.83 -12.							

Table 7-4

802.11b (2.4GHz, SISO) Modulation Interference Factors^{1,2}

		802.11g MIF Measurements [dB]											
Mode		Data Rate [Mbps]											
	6	9	12	18	24	36	48	54					
802.11g	-14.22	-14.22 -13.38 -13.44 -12.68 -11.95 -11.54 -10.94 -11.43											

Table 7-5

802.11g (2.4GHz, SISO) Modulation Interference Factors^{1,2}

			802.1	1g MIF Mea	asurement	s [dB]				
Mode	Data Rate [Mbps]									
	12	18	24	36	24	72	96	108		
802.11g	-14.45	-14.45 -13.55 -13.21 -12.51 -11.54 -11.31 -10.53 -11.44								

Table 7-6

802.11g (2.4GHz, MIMO) Modulation Interference Factors^{1,2}

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

²Note: WLAN MIF values were found to be independent of the transmit channel.

³ Note: All LTE bands were found to have substantially similar MIF values given similar RB and BW configurations.

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	802.11n (2.4GHz) MIF Measurements [dB]												
Mode		Data Rate [Mbps]											
	6.5	13	19.5	26	39	52	58.5	65					
802.11n	-14.44	-14.44 -13.42 -12.76 -12.03 -11.63 -11.26 -11.28 -11.38											

Table 7-7

802.11n (2.4GHz, SISO) Modulation Interference Factors^{1,2}

			802.11n (2	.4GHz) MIF	Measure	nents [dB]				
Mode Data Rate [Mbps]										
	13	26	39	52	78	104	117	130		
802.11n	-14.43	-14.43 -13.39 -12.79 -11.98 -11.53 -11.23 -11.23 -11.36								

Table 7-8

802.11n (2.4GHz, MIMO) Modulation Interference Factors^{1,2}

		802.11ac (2.4GHz) MIF Measurements [dB]										
Mode	Data Rate [Mbps]											
	6.5	13	19.5	26	39	52	58.5	65	78			
802.11ac	-14.52	14.52 -13.56 -12.69 -12.00 -11.48 -11.26 -11.23 -11.35 -11.56										

Table 7-9

802.11ac (2.4GHz, SISO) Modulation Interference Factors^{1,2}

		8	302.11ac (2	2.4GHz) MI	F Measure	ments [dB]			
Mode		Data Rate [Mbps]								
	13	26	39	52	78	104	117	130		
802.11ac	-14.35	-14.35 -13.39 -12.76 -11.93 -11.51 -11.22 -11.20 -11.48								

Table 7-10

802.11ac (2.4GHz, MIMO) Modulation Interference Factors^{1,2}

			802.1	1a MIF Mea	asurement	ts [dB]							
Mode		Data Rate [Mbps]											
	6	9	12	18	24	36	48	54					
802.11a	-14.69	-14.69 -13.85 -13.69 -13.01 -12.19 -11.79 -11.16 -11.70											

Table 7-11

802.11a (5GHz, 20MHz BW, SISO) Modulation Interference Factors^{1,2}

	802.11a MIF Measurements [dB]										
Mode				Data Rat	te [Mbps]						
	12	18	24	36	48	72	96	108			
802.11a	-14.20	-13.62	-13.59	-12.39	-11.77	-11.48	-11.52	-11.14			
				T I I T 40							

Table 7-12

802.11a (5GHz, 20MHz BW, MIMO) Modulation Interference Factors^{1,2}

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: WLAN MIF values were found to be independent of the transmit channel.

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		20MH	Iz BW 802	.11n (5GHz) MIF Mea	surements	s [dB]	
Mode				Data Rat	e [Mbps]			
	6.5	13	19.5	26	39	52	58.5	65
802.11n	-14.65	-13.69	-13.03	-12.28	-11.71	-11.37	-11.38	-11.64

Table 7-13

802.11n (5GHz, 20MHz BW, SISO) Modulation Interference Factors^{1,2}

		20MH	Iz BW 802	.11n (5GHz) MIF Mea	surements	[dB]		
Mode			Data Rate [Mbps]						
	13	26	36	52	78	104	117	130	
802.11n	-14.04	-13.07	-12.46	-11.62	-11.20	-10.94	-10.98	-11.13	

Table 7-14

802.11n (5GHz, 20MHz BW, MIMO) Modulation Interference Factors^{1,2}

	20MHz BW 802.11ac (5GHz) MIF Measurements [dB]										
Mode		Data Rate [Mbps]									
	6.5	13	19.5	26	39	52	58.5	65	78		
802.11ac	-14.64	-13.66	-12.96	-12.05	-11.73	-11.51	-11.44	-11.59	-11.72		

Table 7-15

802.11ac (5GHz, 20MHz BW, SISO) Modulation Interference Factors^{1,2}

	20MHz BW 802.11ac (5GHz) MIF Measurements [dB]									
Mode	Data Rate [Mbps]									
	13	26	36	52	78	104	117	130	156	
802.11ac	-14.17	-13.04	-12.47	-11.64	-11.15	-10.96	-10.98	-11.13	-11.32	

Table 7-16

802.11ac (5GHz, 20MHz BW, MIMO) Modulation Interference Factors^{1,2}

		40MH	Iz BW 802	.11n (5GHz) MIF Mea	surements	; [dB]	
Mode	Data Rate [Mbps]							
	13.5	27	40.5	54	81	108	121.5	135
802.11n	-13.81	-12.48	-11.92	-11.46	-10.95	-10.87	-10.87	-11.03

Table 7-17

802.11n (5GHz, 40MHz BW, SISO) Modulation Interference Factors^{1,2}

40MHz BW 802.11n (5GHz) MIF Measurements [dB]											
Mode				Data Rat	e [Mbps]						
	27	54	81	108	162	216	243	270			
802.11n	-13.36	-12.02	-11.44	-11.05	-10.55	-10.44	-10.41	-10.54			

Table 7-18

802.11n (5GHz, 40MHz BW, MIMO) Modulation Interference Factors^{1,2}

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: WLAN MIF values were found to be independent of the transmit channel.

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40MHz BW 802.11n (5GHz) MIF Measurements [dB]											
Mode					Data Rat	te [Mbps]					
	13.5	27	40.5	54	81	108	121.5	135	162	180	
802.11n	-13.70	-12.62	-11.87	-11.50	-10.89	-10.76	-10.77	-10.97	-11.98	-11.48	
	Table 7-19										

802.11ac (5GHz, 40MHz BW, SISO) Modulation Interference Factors^{1,2}

	40MHz BW 802.11ac (5GHz) MIF Measurements [dB]										
Mode	Data Rate [Mbps]										
	27	54	81	108	162	216	243	270	360		
802.11ac	-13.32	-12.24	-11.44	-11.08	-10.45	-10.35	-10.32	-10.56	-11.07		

Table 7-20

802.11ac (5GHz, 40MHz BW, MIMO) Modulation Interference Factors^{1,2}

80MHz BW 802.11ac (5GHz) MIF Measurements [dB]										
				Data Rat	e [Mbps]					
29.3	58.5	87.8	117	175.5	234	263.3	292.5	351	390	
-12.91	-11.65	-11.13	-10.99	-11.42	-12.28	-12.55	-12.86	-13.24	-13.78	
			29.3 58.5 87.8	29.3 58.5 87.8 117	Data Rat 29.3 58.5 87.8 117 175.5	Data Rate [Mbps] 29.3 58.5 87.8 117 175.5 234	Data Rate [Mbps] 29.3 58.5 87.8 117 175.5 234 263.3	Data Rate [Mbps] 29.3 58.5 87.8 117 175.5 234 263.3 292.5	Data Rate [Mbps] 29.3 58.5 87.8 117 175.5 234 263.3 292.5 351	

Table 7-21

802.11ac (5GHz, 80MHz BW, SISO) Modulation Interference Factors^{1,2}

	80MHz BW 802.11ac (5GHz) MIF Measurements [dB]										
Mode		Data Rate [Mbps]									
	58.5	117	175.5	234	351	468	526.5	585	702	780	
802.11ac	-12.34 -11.23 -10.76 -10.53 -11.12 -11.88 -12.20 -12.49 -13.09 -13.46										
				-							

Table 7-22

802.11ac (5GHz, 80MHz BW, MIMO) Modulation Interference Factors^{1,2}

¹ Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

² Note: WLAN MIF values were found to be independent of the transmit channel.

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8. RF CONDUCTED POWER MEASUREMENTS

I. Procedures Used to Establish RF Signal for HAC Testing

The handset was placed into a simulated call using a base station simulator in a shielded chamber. Such test signals offer a consistent means for testing HAC and are recommended for evaluating HAC. Measurements were taken with a fully charged battery. In order to verify that the device was tested and maintained at full power, this was configured with the base station simulator.

II. HAC Measurement Conditions

Output Power Verification

Maximum output power is verified on the High, Middle and Low channels for all applicable air interfaces. See Table 8-1 for air interface specific settings of transmit power parameters.

Air Interface:	Parameter Name:	Parameter Set To:
GSM	PCL	GSM850: "5"; GSM1900: "0"
UMTS	TPC	"All 1's"
LTE	TPC	"Max Power"
WLAN	Mfr Configured	Mfr Specified

Table 8-1

Power Control Parameters and Settings by Air Interface

III. Setup Used to Measure RF Conducted Powers

Power measurements for licensed modes were performed using a base station simulator under digital average power. Power measurements for unlicensed modes were performed using a power meter and power sensor.



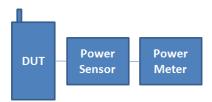


Figure 8-1 Power Measurement Setup for licensed modes

Figure 8-2 Power Measurement Setup for unlicensed modes

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IV. GSM Conducted Powers

Band	[dBm] 128 33.57 190 33.41 251 33.47 512 30.56 661 30.54	(1 Slot)
	128	33.57
GSM 850	190	33.41
	251	(1 Slot) [dBm] 33.57 33.41 33.47 30.56
	512	30.56
GSM 1900	661	30.54
	810	30.45

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V. UMTS Conducted Powers

Mode	Cellu	lar Band	[dBm]	AW	S Band [d	Bm]	PCS	6 Band [d	Bm]
	4132	4183	4233	1312	1412	1513	9262	9400	9538
12.2 kbps RMC	24.63	24.66	24.46	24.70	24.73	24.90	24.85	24.89	24.90
12.2 kbps AMR	24.57	24.65	24.62	24.72	24.73	24.87	24.83	24.76	24.98

VI. LTE Conducted Powers

a. LTE Band 12

	Table 8-2												
LTE Bai	LTE Band 12 (707.5MHz) Conducted Powers – 10MHz Bandwidth												
	LTE Band 12 10 MHz Bandwidth												
			Mid Channel										
Modulation	RB Size	RB Offset	23095 (707.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]								
			Conducted Power [dBm]										
	1	0	24.92		0								
	1	25	24.94	0	0								
	1	49	24.99		0								
QPSK	25	0	23.88		1								
	25	12	23.79	0-1	1								
	25	25	23.79	0-1	1								
	50	0	23.82		1								
	1	0	23.96		1								
	1	25	23.94	0-1	1								
	1	49	23.93		1								
16QAM	25	0	22.90		2								
	25	12	22.87	0-2	2								
	25	25	22.86	0-2	2								
	50	0	22.85		2								

Note: Since LTE Band 12 at 10MHz bandwidth does not support 3 non-overlapping channels, conducted power measurements were made only on the middle channel.

	Table 8-3
LTE Band 12 (707.5M	Hz) Conducted Powers – 5MHz Bandwidth

				LTE Band 12 5 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	23035 (701.5 MHz)	23095 (707.5 MHz)	23155 (713.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			C	Conducted Power [dBm	1]		
	1	0	25.00	24.91	24.95		0
	1	12	24.92	24.98	24.80	0	0
	1	24	24.85	24.93	24.83		0
QPSK	12	0	23.68	23.79	23.78	0-1	1
	12	6	23.71	23.74	23.84		1
	12	13	23.63	23.75	23.80	0-1	1
	25	0	23.65	23.71	23.76		1
	1	0	23.95	23.92	23.74		1
	1	12	23.96	23.94	23.92	0-1	1
	1	24	23.94	23.96	23.74		1
16QAM	12	0	22.71	22.80	22.78		2
	12	6	22.72	22.79	22.81	0-2	2
	12	13	22.71	22.78	22.75	0-2	2
	25	0	22.66	22.79	22.71	1	2

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			2 (707.510112)		0 Wei 3 $=$ 5 Wi		
				LTE Band 12			
				3 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	23025	23095	23165	MPR Allowed per	MPR [dB]
Modulation	110 5126	TID Onset	(700.5 MHz)	(707.5 MHz)	(714.5 MHz)	3GPP [dB]	wirn [cb]
			(Conducted Power [dBm	1]		
	1	0	24.91	24.95	24.90		0
	1	7	24.98	24.80	24.86	0	0
	1	14	24.93	24.83	24.74		0
QPSK	8	0	23.79	23.78	23.85		1
	8	4	23.74	23.84	23.80	0-1	1
	8	7	23.75	23.80	23.74	0-1	1
	15	0	23.71	23.76	23.83		1
	1	0	23.92	23.74	23.88		1
	1	7	23.94	23.92	23.88	0-1	1
	1	14	23.96	23.74	23.84]	1
16QAM	8	0	22.80	22.78	22.82		2
8	8	4	22.79	22.81	22.78	0-2	2
	8	7	22.78	22.75	22.75	0-2	2
	15	0	22.79	22.71	22.80		2

Table 8-4 LTE Band 12 (707.5MHz) Conducted Powers – 3MHz Bandwidth

Table 8-5 LTE Band 12 (707.5MHz) Conducted Powers – 1.4MHz Bandwidth

				LTE Band 12 1.4 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation I	RB Size	RB Offset	23017 (699.7 MHz)	23095 (707.5 MHz)	23173 (715.3 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
				Conducted Power [dBm	1]		
	1	0	24.90	24.68	24.84		0
	1	2	24.92	24.75	24.76		0
	1	5	24.83	24.66	24.59	0	0
QPSK	3	0	24.80	24.94	24.96	0	0
	3	2	24.99	25.00	24.73		0
	3	3	24.93	24.83	24.76		0
	6	0	23.67	23.63	23.74	0-1	1
	1	0	23.89	23.75	23.62		1
	1	2	23.92	23.84	23.79	1	1
	1	5	23.94	23.72	23.67		1
16QAM	3	0	23.81	23.78	23.87	0-1	1
	3	2	23.83	23.91	23.97	1 1	1
	3	3	23.95	23.75	23.95	1 1	1
	6	0	22.76	22.53	22.75	0-2	2

a. LTE Band 13

Table 8-6
LTE Band 13 (780.0MHz) Conducted Powers – 10MHz Bandwidth

			LTE Band 13 10 MHzBandwidth	-	
Modulation	RB Size	RB Size RB Offset	Mid Channel 23230 (782.0 MHz)	MPR Allowed per	MPR [dB]
modulation	TID OILC	no onset	Conducted Power [dBm]	3GPP [dB]	
	1	0	24.64		0
	1	25	24.66	0	0
	1	49	24.58		0
QPSK	25	0	23.48		1
	25	12	23.55	0-1	1
	25	25	23.65		1
	50	0	23.61		1
	1	0	23.67		1
	1	25	23.53	0-1	1
	1	49	23.62		1
16QAM	25	0	22.61		2
	25	12	22.66	0-2	2
	25	25	22.62	0-2	2
	50	0	22.53		2

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	. Danu 13		z) Conducted Po	Dwers – Divinz Ba	andwidth
			LTE Band 13 5 MHzBandwidth		
Modulation	RB Size	RB Offset	Mid Channel 23230 (782.0 MHz) Conducted Power [dBm]	MPR Allowed per 3GPP [dB]	MPR [dB]
	1	0	24.65		0
	1	12	24.62	0	0
	1	24	24.63	Ĩ	0
QPSK	12	0	23.56		1
	12	6	23.31	0-1	1
	12	13	23.39	0-1	1
	25	0	23.44		1
	1	0	23.22		1
	1	12	23.36	0-1	1
	1	24	23.21		1
16QAM	12	0	22.47		2
	12	6	22.24	0-2	2
	12	13	22.32	0-2	2
	25	0	22.43		2

	Table 8-7
LTE Band 13 (780.0MHz) Conducted Powers – 5MHz Bandwidth

Note: Since LTE Band 13 at 5MHz bandwidth does not support 3 non-overlapping channels, conducted power measurements were made only on the middle channel.

b. LTE Band 5

	-		Table 8-8		
LTI	E Band 5 (836.5MHz		wers – 10MHz Ba	andwidth
			LTE Band 5 (Cell) 10 MHz Bandwidth		
	[[Mid Channel		
Modulation	RB Size	RB Offset	20525 (836.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			Conducted Power [dBm]		
	1	0	24.91		0
	1	25	25.00	0	0
	1	49	24.90		0
QPSK	25	0	23.88		1
	25	12	23.85	0-1	1
	25	25	23.87	0-1	1
	50	0	23.84		1
	1	0	23.97		1
	1	25	23.77	0-1	1
	1	49	23.97		1
16QAM	25	0	22.92		2
	25	12	22.86	0-2	2
	25	25	22.88	0-2	2
	50	0	22.89		2

Note: Since LTE Band 5 at 10MHz bandwidth does not support 3 non-overlapping channels, conducted power measurements were made only on the middle channel.

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			5 (000.510112)	Conducted P		2 Danawiatii	
				LTE Band 5 (Cell) 5 MHz Bandwidth			
		1	Low Channel	Mid Channel	High Channel	г	
Modulation	RB Size	RB Offset	20425 (826.5 MHz)	20525 (836.5 MHz)	20625 (846.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			1	Conducted Power [dBm	ı]		
	1	0	24.91	24.94	24.94		0
	1	12	24.99	24.90	24.96	0	0
	1	24	24.93	24.98	24.95		0
QPSK	12	0	23.79	23.69	23.79		1
	12	6	23.73	23.74	23.79	0-1	1
	12	13	23.78	23.75	23.77		1
	25	0	23.74	23.70	23.66	1	1
	1	0	23.76	23.94	24.00		1
	1	12	23.85	23.96	23.82	0-1	1
	1	24	23.85	23.98	23.90	1 1	1
16QAM	12	0	22.88	22.72	22.82	1	2
	12	6	22.83	22.82	22.82		2
	12	13	22.86	22.77	22.79	0-2	2
	25	0	22.72	22.75	22.70	1 1	2

Table 8-9 I TE Band 5 (836 5MHz) Conducted Powers – 5MHz Bandwidth

Table 8-10 LTE Band 5 (836.5MHz) Conducted Powers – 3MHz Bandwidth

				LTE Band 5 (Cell) 3 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	20415 (825.5 MHz)	20525 (836.5 MHz)	20635 (847.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
				Conducted Power [dBm	ı]		
	1	0	24.96	24.97	24.73		0
	1	7	24.97	24.95	24.75	0	0
	1	14	24.85	24.98	24.72		0
QPSK	8	0	23.89	23.70	23.77		1
	8	4	23.87	23.75	23.70	0-1	1
	8	7	23.96	23.73	23.71	0-1	1
	15	0	23.95	23.77	23.73		1
	1	0	24.00	23.75	23.79		1
	1	7	23.95	23.85	23.73	0-1	1
16QAM	1	14	23.96	23.89	23.83		1
	8	0	22.99	22.66	22.77		2
	8	4	22.94	22.75	22.72	0-2	2
	8	7	22.85	22.71	22.61	0-2	2
	15	0	22.97	22.70	22.71	1	2

Table 8-11 LTE Band 5 (836.5MHz) Conducted Powers – 1.4MHz Bandwidth

			Low Channel	Mid Channel	High Channel		
lodulation	RB Size	RB Offset	20407 (824.7 MHz)	20525 (836.5 MHz)	20643 (848.3 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
		[Conducted Power [dBn	ו]		
	1	0	24.93	24.94	24.73		0
	1	2	24.97	24.95	24.88	1	0
	1	5	24.95	24.90	24.80		0
QPSK	3	0	24.82	24.89	24.92		0
	3	2	24.92	24.90	24.75		0
	3	3	24.83	24.80	24.80	1	0
	6	0	23.78	23.70	23.84	0-1	1
	1	0	23.94	23.74	23.68		1
	1	2	23.92	23.85	23.67		1
	1	5	23.93	23.69	23.67	0-1	1
16QAM	3	0	23.91	23.80	23.91	0-1	1
	3	2	23.95	23.85	23.80	1 [1
	3	3	23.92	23.75	23.78	1 – – – – –	1
	6	0	22.93	22.64	22.70	0-2	2

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c. LTE Band 66

				LTE Band 66 (AWS) 20 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	132072 (1720.0 MHz)	132322 (1745.0 MHz)	132572 (1770.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm	i]		
	1	0	24.96	24.93	25.00		0
	1	50	24.90	24.90	24.91	0	0
	1	99	24.92	24.87	24.95		0
QPSK	50	0	23.88	23.95	23.88	0-1	1
	50	25	23.96	23.97	23.84		1
	50	50	23.71	23.98	23.72		1
	100	0	23.85	23.92	23.82		1
	1	0	23.92	23.95	23.91		1
	1	50	23.90	24.00	23.99	0-1	1
	1	99	23.91	24.00	24.00	1 1	1
16QAM	50	0	22.90	22.87	22.91		2
	50	25	22.96	23.00	22.89	0-2	2
	50	50	22.67	22.94	22.74	0-2	2
i i i	100	0	22.84	22.98	22.93	1 1	2

Table 8-12 - CC /1745 OMU-. _ _ _

Table 8-13 LTE Band 66 (1745.0MHz) Conducted Powers – 15MHz Bandwidth

				LTE Band 66 (AWS) 15 MHz Bandwidth			
Modulation	RB Size	RB Offset	Low Channel 132047 (1717.5 MHz)	Mid Channel 132322 (1745.0 MHz)	High Channel 132597 (1772.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			C	Conducted Power [dBm]		
	1	0	24.93	24.89	24.99		0
	1	36	24.94	24.96	24.95	0	0
	1	74	24.96	25.00	24.86		0
QPSK	36	0	23.88	23.95	23.92	0-1	1
	36	18	23.91	23.91	23.91		1
	36	37	23.83	23.91	23.82		1
	75	0	23.85	23.87	23.96		1
	1	0	23.95	23.95	23.91		1
	1	36	23.94	23.98	23.92	0-1	1
	1	74	23.63	23.93	23.97		1
16QAM	36	0	22.89	22.96	22.99		2
	36	18	22.89	22.93	22.91	0.2	2
	36	37	22.81	22.94	22.85	0-2	2
	75	0	22.86	22.86	22.95		2

Table 8-14 LTE Band 66 (1745.0MHz) Conducted Powers – 10MHz Bandwidth

			-	LTE Band 66 (AWS) 10 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	132022 (1715.0 MHz)	132322 (1745.0 MHz)	132622 (1775.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm	ו]		
	1	0	24.95	24.99	25.00		0
	1	25	24.96	24.85	24.99	0	0
	1	49	24.96	25.00	24.91		0
QPSK	25	0	23.97	23.82	23.94		1
	25	12	23.95	23.91	23.93	0-1	1
	25	25	23.91	23.94	23.99		1
	50	0	23.98	23.97	23.98		1
	1	0	23.95	23.91	23.92		1
	1	25	23.91	24.00	23.96	0-1	1
	1	49	23.93	23.98	23.90		1
16QAM	25	0	22.94	22.76	22.98		2
	25	12	22.95	22.93	22.95	0-2	2
	25	25	22.95	23.00	22.94		2
	50	0	22.96	22.99	22.98		2

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LIE Band 66 (1745.0MHZ) Conducted Powers – 5MHZ Bandwidth								
				LTE Band 66 (AWS) 5 MHz Bandwidth				
			Low Channel	Mid Channel	High Channel			
Modulation	RB Size	RB Offset	131997	132322	132647	MPR Allowed per	MPR [dB]	
modulution			(1712.5 MHz)	(1745.0 MHz)	(1777.5 MHz)	3GPP [dB]		
			(Conducted Power [dBm	1]			
	1	0	24.94	24.95	24.93	0	0	
	1	12	24.85	24.89	24.92		0	
	1	24	24.91	24.95	24.90		0	
QPSK	12	0	23.92	23.82	24.00	0-1	1	
	12	6	23.91	23.91	23.87		1	
	12	13	23.86	23.89	23.90		1	
	25	0	23.92	23.89	23.90		1	
	1	0	23.91	23.97	23.99		1	
	1	12	23.91	23.97	23.92	0-1	1	
	1	24	23.99	23.90	23.94		1	
16QAM	12	0	22.94	22.87	22.94		2	
	12	6	22.90	22.90	22.91	0-2	2	
	12	13	22.87	22.98	22.93	0-2	2	
	25	0	22.99	22.87	22.95		2	

Table 8-15 LTE Band 66 (1745.0MHz) Conducted Powers – 5MHz Bandwidth

d. LTE Band 2

Table 8-16 LTE Band 2 (1880.0MHz) Conducted Powers – 20MHz Bandwidth

	LTE Band 2 (PCS) 20 MHz Bandwidth								
Modulation	RB Size	RB Offset	Low Channel 18700 (1860.0 MHz)	Mid Channel 18900 (1880.0 MHz)	High Channel 19100 (1900.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]		
			(Conducted Power [dBm]				
	1	0	25.19	25.14	25.16		0		
	1	50	25.16	25.16	25.17	0	0		
	1	99	25.08	25.11	25.17		0		
QPSK	50	0	24.16	24.01	23.98	0-1	1		
	50	25	24.07	23.95	24.02		1		
	50	50	24.00	23.93	24.04		1		
	100	0	24.05	23.90	23.97		1		
	1	0	24.15	24.18	24.00		1		
	1	50	24.11	24.15	24.02	0-1	1		
	1	99	24.14	24.14	24.01		1		
16QAM	50	0	23.17	22.97	23.03		2		
	50	25	23.12	22.99	23.10	0-2	2		
	50	50	23.01	22.88	23.05	0-2	2		
	100	0	23.08	22.95	23.05		2		

 Table 8-17

 LTE Band 2 (1880.0MHz) Conducted Powers – 15MHz Bandwidth

				LTE Band 2 (PCS)			
				15 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	18675 (1857.5 MHz)	18900 (1880.0 MHz)	19125 (1902.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm]		
	1	0	25.10	25.20	25.17		0
	1	36	25.12	24.97	25.18	0	0
	1	74	25.18	24.89	25.16		0
QPSK	36	0	23.99	23.99	24.05	0-1	1
	36	18	24.05	23.93	24.10		1
	36	37	23.92	23.92	24.12		1
	75	0	23.98	23.97	24.10		1
	1	0	24.12	24.08	24.10		1
	1	36	24.10	24.08	24.15	0-1	1
	1	74	24.19	24.03	24.20		1
16QAM	36	0	23.08	23.05	23.14		2
	36	18	23.15	22.93	23.11	0-2	2
	36	37	23.07	22.96	23.12		2
	75	0	23.00	22.94	23.00	1	2

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	<u> </u>		(1000.010112)	Conducted PC			
				LTE Band 2 (PCS) 10 MHz Bandwidth			
	-	r	Lew Obernel		Link Ohennel	1	
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	18650 (1855.0 MHz)	18900 (1880.0 MHz)	19150 (1905.0 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm	1]		
	1	0	25.18	25.18	25.18	0	0
	1	25	25.16	25.09	25.20		0
	1	49	25.20	25.09	25.12		0
QPSK	25	0	24.14	24.13	24.19	0-1	1
	25	12	24.19	24.03	24.19		1
	25	25	24.10	24.01	24.13		1
	50	0	24.18	24.02	24.13		1
	1	0	24.17	24.12	24.13		1
	1	25	24.17	24.07	24.20	0-1	1
	1	49	24.10	24.17	24.19		1
16QAM	25	0	23.20	22.97	23.15		2
	25	12	23.20	23.09	23.13	0.2	2
	25	25	23.19	23.08	23.05	0-2	2
	50	0	23.16	23.06	23.20		2

Table 8-18 LTE Band 2 (1880 0MHz) Conducted Powers – 10MHz Bandwidth

Table 8-19 LTE Band 2 (1880.0MHz) Conducted Powers – 5MHz Bandwidth

				LTE Band 2 (PCS) 5 MHz Bandwidth			
Modulation	RB Size	RB Offset	Low Channel 18625 (1852.5 MHz)	Mid Channel 18900 (1880.0 MHz)	High Channel 19175 (1907.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
				Conducted Power [dBm	ı]		
	1	0	25.18	25.00	25.19		0
	1	12	25.14	24.89	25.17	0	0
QPSK	1	24	25.18	24.79	25.10		0
	12	0	24.16	23.93	24.19	0-1	1
	12	6	24.14	23.97	24.18		1
	12	13	24.14	23.87	24.05		1
	25	0	24.10	23.95	24.18		1
	1	0	24.11	24.12	24.18		1
	1	12	24.18	24.13	24.19	0-1	1
	1	24	24.11	24.09	24.19	1	1
16QAM	12	0	23.12	23.01	23.18		2
	12	6	23.13	23.01	23.04	0.2	2
	12	13	23.20	22.83	23.15	0-2	2
	25	0	23.15	22.95	23.20		2

	Table 8-20
LTE Band 2 (1880.0M	Hz) Conducted Powers – 3MHz Bandwidth

				LTE Band 2 (PCS) 3 MHz Bandwidth			
			Low Channel	Mid Channel	High Channel		
Modulation	RB Size	RB Offset	18615 (1851.5 MHz)	18900 (1880.0 MHz)	19185 (1908.5 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm	1]		
	1	0	25.11	25.01	25.19		0
	1	7	25.16	25.11	25.13	0	0
	1	14	25.14	24.90	25.09]	0
QPSK	8	0	24.13	24.05	24.01		1
	8	4	24.13	23.97	24.01	0-1	1
	8	7	24.10	23.99	24.03		1
	15	0	24.11	23.95	24.10		1
	1	0	24.15	24.16	24.10		1
	1	7	24.12	24.04	24.19	0-1	1
	1	14	24.20	24.13	24.09	1 1	1
16QAM	8	0	23.17	23.00	23.03		2
	8	4	23.12	22.98	23.11	0.2	2
	8	7	23.16	22.87	23.09	0-2	2
	15	0	23.20	22.88	23.17	1 1	2

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			. (1000.000112)			Danawiatii	
	LTE Band 2 (PCS) 1.4 MHz Bandwidth						
	1	1	Low Channel	Mid Channel	High Channel	1	
						I	
Modulation	RB Size	RB Offset	18607 (1850.7 MHz)	18900 (1880.0 MHz)	19193 (1909.3 MHz)	MPR Allowed per 3GPP [dB]	MPR [dB]
			(Conducted Power [dBm	ו]		
	1	0	25.13	24.82	25.13		0
	1	2	25.18	25.00	25.14	1	0
QPSK 3 3 3	1	5	25.13	24.84	25.14	0	0
	3	0	24.99	25.15	25.19		0
	3	2	25.11	25.18	25.19		0
	3	3	25.17	25.08	25.20		0
	6	0	24.03	23.93	24.13	0-1	1
	1	0	24.15	24.07	24.14		1
	1	2	24.20	24.07	24.17		1
	1	5	24.11	23.94	23.90	0-1	1
16QAM	3	0	24.13	24.19	24.09	1	1
	3	2	24.13	24.08	24.11	1 1	1
	3	3	24.11	24.05	24.19	1 1	1
	6	0	23.10	22.73	23.12	0-2	2

Table 8-21 LTE Band 2 (1880.0MHz) Conducted Powers – 1.4MHz Bandwidth

VII. WLAN Conducted Powers

Table 8-22 IEEE 802.11b/g/n/ac (2.4GHz, SISO, Primary Antenna) Reduced RF Power ¹						
		2.4GHz Conducted Power [dBm] IEEE Transmission Mode				
Freq [MHz]	Channel					
		802.11b	802.11g	802.11n	802.11ac	
2412	1	15.43	14.09	14.01	14.03	
2437	6	15.96	14.56	14.79	14.69	
2462	11	15.93	13.09	13.09	13.09	

 Table 8-23

 IEEE 802.11g/n/ac (2.4GHz, MIMO) Reduced RF Power¹

		2.4GHz Conducted Power [dBm]			
Freq [MHz]	Channel	IEEE Transmission Mod		Mode	
		802.11g	802.11n	802.11ac	
2412	1	16.10	15.96	15.93	
2437	6	16.44	16.60	16.53	
2462	11	15.49	15.49	15.50	

¹Note: This device utilizes independent power reduction mechanisms for the WLAN transmitter in all WLAN modes for held-to-ear scenarios.

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		5GHz (20MHz) Conducted Power [dBm]				
Freq [MHz]	Channel	IEEE Transmission Mode				
		802.11a	802.11n	802.11ac		
5180	36	12.09	12.03	12.01		
5200	40	12.05	12.00	12.07		
5220	44	12.10	12.05	12.17		
5240	48	12.22	12.13	12.12		
5260	52	12.42	12.08	12.20		
5280	56	12.47	12.09	12.15		
5300	60	12.47	12.22	12.16		
5320	64	12.33	12.09	12.24		
5500	100	12.33	12.24	12.25		
5580	116	12.43	11.77	12.21		
5660	132	12.22	12.02	12.01		
5720	144	12.05	12.00	11.83		
5745	149	12.23	12.26	12.14		
5785	157	12.18	12.24	12.22		
5825	165	12.12	12.17	12.21		

 Table 8-24

 IEEE 802.11a/n/ac (5GHz, 20MHz BW, SISO, Primary Antenna) Reduced RF Power¹

 Table 8-25

 IEEE 802.11a/n/ac (5GHz, 20MHz BW, MIMO) Reduced RF Power¹

		5GHz (20MHz) Conducted Power [dBm]				
Freq [MHz]	Channel	IEEE Transmission Mode				
		802.11a	802.11n	802.11ac		
5180	36	13.78	13.71	13.70		
5200	40	13.78	13.75	13.80		
5220	44	13.78	13.76	13.83		
5240	48	13.89	13.84	13.77		
5260	52	14.00	13.77	13.85		
5280	56	14.02	13.81	13.78		
5300	60	14.02	13.86	13.83		
5320	64	13.98	13.79	13.92		
5500	100	13.98	13.90	13.89		
5580	116	14.02	13.52	13.90		
5660	132	13.91	13.76	13.71		
5720	144	13.77	13.76	13.65		
5745	149	13.90	13.92	13.85		
5785	157	13.88	13.87	13.90		
5825	165	13.83	13.83	13.86		

¹Note: This device utilizes independent power reduction mechanisms for the WLAN transmitter in all WLAN modes for held-to-ear scenarios.

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	Channal	5GHz (40MHz) Conducted Power [dBm]		
Freq [MHz]	Channel	IEEE Transmission Mode		
		802.11n	802.11ac	
5190	38	11.54	11.57	
5230	46	12.23	12.14	
5270	54	11.95	11.81	
5310	62	11.31	11.10	
5510	102	11.34	11.33	
5550	110	12.68	12.81	
5670	134	12.63	12.67	
5710	142	12.62	12.68	
5755	151	12.38	12.42	
5795	159	12.40	12.49	

 Table 8-26

 IEEE 802.11n/ac (5GHz, 40MHz BW, SISO, Primary Antenna) Reduced RF Power¹

 Table 8-27

 IEEE 802.11n/ac (5GHz, 40MHz BW, MIMO) Reduced RF Power¹

Freq [MHz]	Channel	5GHz (40MHz Power	•
Fied [MHz]	Channel	IEEE Transm	ission Mode
		802.11n	802.11ac
5190	38	13.46	13.40
5230	46	13.89	13.84
5270	54	13.70	13.58
5310	62	13.30	13.14
5510	102	13.32	13.31
5550	110	14.18	14.29
5670	134	14.18	14.21
5710	142	14.16	14.16
5755	151	14.01	14.02
5795	159	14.03	14.07

¹Note: This device utilizes independent power reduction mechanisms for the WLAN transmitter in all WLAN modes for held-to-ear scenarios.

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Table 8-28		
IEEE 802.11ac (5GHz, 80MHz BW, SISO, Primary	Antenna)	Reduced RF Power ¹

5GHz (80MHz) Conducted Power [dBm]				
Freq [MHz]	Channel	IEEE Transmission Mode		
		802.11ac		
5210	42	10.90		
5290	58	10.53		
5530	106	10.01		
5690	138	12.06		
5775	155	11.93		

Table 8-29 IEEE 802.11ac (5GHz, 80MHz BW, MIMO) Reduced RF Power¹

5GHz (80N	5GHz (80MHz) Conducted Power [dBm]								
Freq [MHz]	eq [MHz] Channel								
		802.11ac							
5210	42	13.02							
5290	58	12.74							
5530	106	12.52							
5690	138	13.79							
5775	155	13.69							

¹Note: This device utilizes independent power reduction mechanisms for the WLAN transmitter in all WLAN modes for held-to-ear scenarios.

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9. JUSTIFICATION OF HELD TO EAR MODES TESTED

I. Analysis of RF Air Interface Technologies

- **a.** According to the April 2013 TCB workshop slides, OTT data services are outside the current definition of a managed CMRS service and are currently not required to be evaluated.
- b. No associated T-coil measurements for VoLTE or VoIP over WIFI CMRS have been made in accordance with the guidance issued by OET in KDB publication 285076 D02 T-Coil testing for CMRS IP.
- c. An analysis was performed, following the guidance of §4.3 and §4.4 of the ANSI standard, of the RF air interface technologies being evaluated. The factors that will affect the RF interference potential were evaluated, and the worst case operating modes were identified and used in the evaluation. A WD's interference potential is a function both of the WD's average near-field field strength and of the signal's audio-frequency amplitude modulation characteristics. Per §4.4, RF air interface technologies that have low power have been found to produce sufficiently low RF interference potential, so it is possible to exempt them from the product testing specified in Clause 5 of the ANSI standard. An RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is ≤17dBm for all of its operating modes. RF air interface technologies exempted from testing in this manner are automatically assigned an M4 rating to be used in determining the overall rating for the WD.

The worst case MIF plus the worst case average antenna input power for all modes are investigated below to determine the testing requirements for this device.

Air Interface	Maximum Average Power (dBm)	Worst Case MIF (dB)	Total (Power + MIF, dB)	C63.19 Testing Required
GSM850	24.54*	3.54	28.08	Yes
GSM1900	21.53*	3.54	25.07	Yes
UMTS - RMC**	24.90	-22.97	1.93	No
UMTS - AMR**	24.98	-12.77	12.21	No
LTE - FDD**	25.20	-9.42	15.78	No
2.4GHz WLAN	16.60	-10.53	6.07	No
5GHz WLAN	14.29	-10.32	3.97	No

II. Individual Mode Evaluations

 Table 9-1

 Max Power + MIF calculations

 for Low Power Exemptions

* Note: ANSI C63.19-2011 Sec. 4.4 Footnote 20 indicates the use of a long averaging time for measuring the antenna input power when using this method of exclusion. Therefore, the frame averaged power was calculated for these modes in this investigation.

** Note: These modes support operation utilizing the diversity antenna (Ant 3) for some bands (UMTS 850 and LTE Bands 5, 12, and 13). However, the worst-case values across all possible antennae are used in this investigation. Therefore, the results of this investigation are applicable to all possible antennae.

III. Low-Power Exemption Conclusions

Per ANSI C63.19-2011, RF Emissions testing for this device is required only for GSM voice modes. All other air interfaces are exempt, including all modes which transmit on the diversity antenna (Ant 3).

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OVERALL MEASUREMENT SUMMARY 10.

FCC ID:	ZNFH918
Model:	LG-H918, LGH918, H918, LG-H910PR, LGH910PR, H910PR
S/N:	09411

I. E-FIELD EMISSIONS:

	HAC Data Summary for E-field											
Mode	Channel	Antenna Config.	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC MARGIN (dB)	RESULT	Excl Blocks per 5.5
E-field Emis	ssions											
GSM850	128	Ant 1	Acoustic	33.57	50.90	34.13	3.51	37.64	45.00	-7.36	M4	none
GSM850	190	Ant 1	Acoustic	33.41	46.78	33.40	3.53	36.93	45.00	-8.07	M4	none
GSM850	251	Ant 1	Acoustic	33.47	42.84	32.64	3.54	36.18	45.00	-8.82	M4	none
								•				
GSM1900	512	Ant 2	Acoustic	30.56	15.96	24.06	3.54	27.60	35.00	-7.40	M4	6, 8, 9
GSM1900	661	Ant 2	Acoustic	30.54	13.94	22.89	3.54	26.43	35.00	-8.57	M4	6, 8, 9
GSM1900	810	Ant 2	Acoustic	30.45	16.15	24.16	3.54	27.70	35.00	-7.30	M4	6, 8, 9
GSM1900	810	Ant 2	T-coil	30.45	16.15	24.16	3.54	27.70	35.00	-7.30	M4	6, 8, 9

Table 10-1

Figure 10-1 Sample E-field Scan Overlay (See Test Setup Photographs for actual WD overlay)

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FCC ID:	ZNFH918
Model:	LG-H918, LGH918, H918, LG-H910PR, LGH910PR, H910PR
S/N:	09411

II. Worst-case Configuration Evaluation

Peak Reading 360° Probe Rotation at Azimuth axis											
Mode	Channel	Antenna Config.	Scan Center	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC MARGIN (dB)	RESULT	Excl Blocks per 5.5
Probe Rotation at Worst-Case											
GSM1900	810	Ant 2	Acoustic	15.64	23.89	3.54	27.43	35.00	-7.57	M4	6, 8, 9

Table 10-2

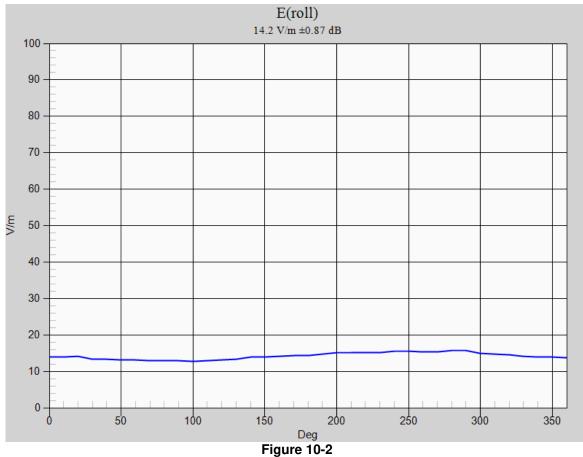


Figure 10-2 Worst-Case Probe Rotation about Azimuth axis

* Note: Locations of probe rotation (with and without exclusions) are shown in Figure 10-1 denoted by the green square markers.

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11. EQUIPMENT LIST

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
Agilent	E4438C	ESG Vector Signal Generator	3/13/2015	Biennial	3/13/2017	MY42082659
Agilent	E4432B	ESG-D Series Signal Generator	3/5/2016	Annual	3/5/2017	US40053896
Agilent	N5182A	MXG Vector Signal Generator	3/5/2016	Annual	3/5/2017	MY47420800
Amplifier Research	15S1G6	Amplifier	N/A	CBT*	N/A	433978
Anritsu	ML2496A	Power Meter	3/5/2016	Annual	3/5/2017	1351001
Anritsu	MA2481A	Power Sensor	3/3/2016	Annual	3/3/2017	5318
Anritsu	MA2481A	Power Sensor	3/3/2016	Annual	3/3/2017	2400
Anritsu	MA2411B	Pulse Power Sensor	12/7/2015	Annual	12/7/2016	1339018
Anritsu	MA2411B	Pulse Power Sensor	2/28/2016	Annual	2/28/2017	1207470
Anritsu	MA24106A	USB Power Sensor	6/2/2016	Annual	6/2/2017	1244512
Anritsu	MA24106A	USB Power Sensor	6/2/2016	Annual	6/2/2017	1248508
Mini-Circuits	NLP-1200+	Low Pass Filter DC to 1000 MHz	N/A	CBT*	N/A	N/A
Mini-Circuits	NLP-2950+	Low Pass Filter DC to 2700 MHz	N/A	CBT*	N/A	N/A
Mini-Circuits	BW-N20W5	Power Attenuator	N/A	CBT*	N/A	1226
Pasternack	PE2237-20	Bidirectional Coupler	N/A	CBT*	N/A	N/A
Pasternack	NC-100	Torque Wrench	11/6/2015	Biennial	11/6/2017	N/A
Rohde & Schwarz	CMW500	Radio Communication Tester	4/6/2016	Annual	4/6/2017	128635
SPEAG	AIA	Audio Interference Analzyer	N/A	CBT*	N/A	1010
SPEAG	DAE4	Dasy Data Acquisition Electronics	11/11/2015	Annual	11/11/2016	1334
SPEAG	CD1880V3	Freespace 1880 MHz Dipole	5/12/2016	Biennial	5/12/2018	1064
SPEAG	CD835V3	Freespace 835 MHz Dipole	5/10/2016	Biennial	5/10/2018	1082
SPEAG	ER3DV6	Freespace E-field Probe	8/24/2015	Annual	8/24/2016	2335

Table 11-1 Equipment List

Calibration traceable to the National Institute of Standards and Technology (NIST).

*Note: CBT (Calibrated Before Testing). Prior to testing, the measurement paths containing a cable, attenuator, coupler or filter were connected to a calibrated source (i.e. a signal generator) to determine the losses of the measurement path. The power meter offset was then adjusted to compensate for the measurement system losses. This level offset is stored within the power meter before measurements are made. This calibration verification procedure applies to the system verification and output power measurements. The calibrated reading is then taken directly from the power meter after compensation of the losses for all final power measurements.

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12. MEASUREMENT UNCERTAINTY

Wireless Communications Device Near-Field Measurement Uncertainty Estimation							
Uncertainty Component	Data (dB)	Data Type	Prob. Dist.	Divisor	Ci (E)	Unc. (dB)	Notes/Comments
Measurement System							
RF System Reflections	0.50	Tolerance	Ν	1.00	1	0.50	* Refl. < -20 dB
Field Probe Calibration	0.21	Tolerance	Ν	1.00	1	0.21	
Field Probe Isotropy	0.01	Tolerance	Ν	1.00	1	0.01	
Field Probe Frequency Response	0.135	Tolerance	Ν	1.00	1	0.14	
Field Probe Linearity	0.013	Tolerance	Ν	1.00	1	0.01	
Modulation Interference Factor	0.20	Tolerance	R	1.73	1	0.12	Applicable for M-rating testing
Boundary Effects	0.105	Accuracy	R	1.73	1	0.06	*
Probe Positioning Accuracy	0.20	Accuracy	R	1.73	1	0.12	*
Probe Positioner	0.050	Accuracy	R	1.73	1	0.03	*
Extrapolation/Interpolation	0.045	Tolerance	R	1.73	1	0.03	*
Resolution to 2mm error	0.21	Tolerance	Ν	1.00	1	0.21	
System Detection Limit	0.05	Tolerance	R	1.73	1	0.03	*
Readout Electronics	0.015	Tolerance	Ν	1.00	1	0.02	*
Integration Time	0.11	Tolerance	R	1.73	1	0.06	*
Response Time	0.033	Tolerance	R	1.73	1	0.02	*
Phantom Thickness	0.10	Tolerance	R	1.73	1	0.06	*
System Repeatability (Field x 2=power)	0.17	Tolerance	Ν	1.00	1	0.17	*
Test Sample Related							
Device Positioning Vertical	0.2	Tolerance	R	1.73	1	0.12	*
Device Positioning Lateral	0.045	Tolerance	R	1.73	1	0.03	*
Device Holder and Phantom	0.1	Tolerance	R	1.73	1	0.06	*
Power Drift	0.21	Tolerance	R	1.73	1	0.12	
Combined Standard Uncertainty (k=1)						0.66	16.3%
Expanded Uncertainty [95% confidence]					1.31	32.6%	
Expanded Uncertainty [95% confidence]	Expanded Uncertainty [95% confidence] on Field					0.66	16.3%

Table 12-1

Uncertainty Estimation Table

Notes:

- 1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297. All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.
- 2. * Uncertainty specifications from Schmidt & Partner Engineering AG (not site specific)

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurements (so-called Type A uncertainty). This may mean that the Hearing Aid immunity tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurements to identify the measurement uncertainty. By combining the repeat measurements to identify the measurement uncertainty. By and NIS 3003, the overall measurement uncertainty was estimated.

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13. TEST DATA

See following Attached Pages for Test Data.

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PCTEST Hearing-Aid Compatibility Facility

DUT: CD835V3 - SN1082

Type: CD835V3 Serial: 1082

Communication System: CW; Frequency: 835 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 SN2335; Calibrated: 08/24/2015
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1334; Calibrated: 11/11/2015
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8);

835 MHz / 100mW HAC Dipole Validation at 15mm /Hearing Aid Compatibility Test (41x361x1):



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Date: 08/08/2016



PCTEST Hearing-Aid Compatibility Facility

DUT: CD1880V3 - SN1064

Type: CD1880V3 Serial: 1064

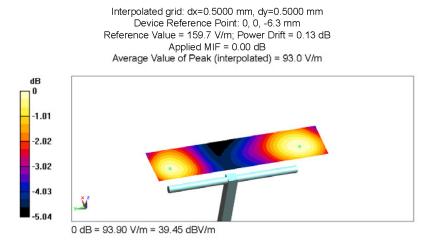
Communication System: CW; Frequency: 1880 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 SN2335; Calibrated: 08/24/2015
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1334; Calibrated: 11/11/2015
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8);

1880 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x181x1):



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DUT: ZNFH918

Type: Portable Handset Serial: 09411 Backlight off Duty Cycle: 1:8.3

Communication System: GSM; Frequency: 824.2 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

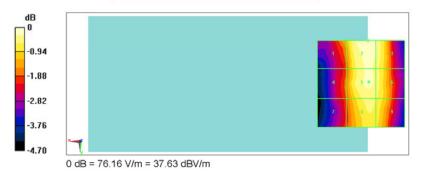
- Probe: ER3DV6 SN2335; Calibrated: 08/24/2015
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1334; Calibrated: 11/11/2015
- · Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8);

GSM850 Low Channel/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 65.38 V/m; Power Drift = -0.07 dB Applied MIF = 3.51 dB RF audio interference level = 37.64 dBV/m **Emission category: M4**

MIF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
36.47 dBV/m	37.64 dBV/m	37.39 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
35.98 dBV/m	37.4 dBV/m	37.25 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
35.77 dBV/m	37.15 dBV/m	37.05 dBV/m



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DUT: ZNFH918

Type: Portable Handset Serial: 09411 Backlight off Duty Cycle: 1:8.3

Communication System: GSM; Frequency: 1909.8 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: ER3DV6 SN2335; Calibrated: 08/24/2015
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1334; Calibrated: 11/11/2015
- · Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.8 (8);

GSM1900 High Channel/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 13.99 V/m; Power Drift = -0.04 dB Applied MIF = 3.54 dB RF audio interference level = 27.70 dBV/m **Emission category: M4**

MIF scaled E-field

Grid 1 M4		Grid 3 M4
26.2 dBV/m	27.7 dBV/m	27.59 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
23.72 dBV/m	27.36 dBV/m	27.56 dBV/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
27.5 dBV/m	29.55 dBV/m	29.54 dBV/m



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14. CALIBRATION CERTIFICATES

The following pages include the probe calibration used to evaluate HAC for the DUT.

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Calibration Laborato Schmid & Partner Engineering AG ^{Zeughausstrasse 43, 8004 Zuri}	•	BC MRA	Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service
Accredited by the Swiss Accredit The Swiss Accreditation Servio Multilateral Agreement for the s	ce is one of the signatories	s to the EA	reditation No.: SCS 0108
Client PC Test			ER3-2335_Aug15/2
CALIBRATION	CERTIFICATE	E (Replacement of No: EF	R3-2335_Aug15)
Object	ER3DV6 - SN:23	35	
Calibration procedure(s)	QA CAL-02.v8, C Calibration proce evaluations in air	dure for E-field probes optimized f	or close near field
Calibration date:	August 24, 2015		$\sqrt{P_{1}}$
The measurements and the unc	ertainties with confidence pr	onal standards, which realize the physical units obability are given on the following pages and y facility: environment temperature $(22 \pm 3)^{\circ}$ C é	are part of the certificate.
The measurements and the unc	ertainties with confidence pr ucted in the closed laborator	obability are given on the following pages and	are part of the certificate.
The measurements and the unc All calibrations have been condu Calibration Equipment used (M8 	ertainties with confidence pr ucted in the closed laborator &TE critical for calibration)	obability are given on the following pages and y facility: environment temperature (22 ± 3)°C a Cal Date (Certificate No.)	are part of the certificate. and humidity < 70%.
The measurements and the unc All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E4419B	ertainties with confidence pr ucted in the closed laborator RTE critical for calibration)	obability are given on the following pages and y facility: environment temperature (22 ± 3)°C a Cal Date (Certificate No.) 01-Apr-15 (No. 217-02128)	are part of the certificate. and humidity < 70%. Scheduled Calibration Mar-16
The measurements and the unc All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E44198 Power sensor E4412A	ertainties with confidence pr ucted in the closed laborator &TE critical for calibration) ID GB41293874 MY41498087	Cal Date (Certificate No.) 01-Apr-15 (No. 217-02128)	are part of the certificate. and humidity < 70%. Scheduled Calibration Mar-16 Mar-16
The measurements and the unc All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E44198 Power sensor E4412A Reference 3 dB Altenuator	ertainties with confidence pr ucted in the closed laborator &TE critical for calibration) ID GB41293874 MY41498087 SN: S5054 (3c)	Cal Date (Certificate No.) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02128)	are part of the certificate. and humidity < 70%. Scheduled Calibration Mar-16 Mar-16 Mar-16
The measurements and the unc All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator	ertainties with confidence pr ucted in the closed laborator &TE critical for calibration) ID GB41293874 MY41498087 SN: S5054 (3c) SN: S5277 (20x)	Obability are given on the following pages and y facility: environment temperature (22 ± 3)°C a Cal Date (Certificate No.) 01-Apr-15 (No. 217-02128)	are part of the certificate. and humidity < 70%. Scheduled Calibration Mar-16 Mar-16
The measurements and the unc All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E44198 Power sensor E4412A Reference 3 dB Altenuator	ertainties with confidence pr ucted in the closed laborator &TE critical for calibration) ID GB41293874 MY41498087 SN: S5054 (3c)	Cal Date (Certificate No.) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02128)	are part of the certificate. and humidity < 70%. Scheduled Calibration Mar-16 Mar-16 Mar-16 Mar-16
The measurements and the unc All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E4419B Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator	ertainties with confidence pr ucted in the closed laborator RTE critical for calibration) ID GB41293874 MY41498087 SN: S5054 (3c) SN: S5054 (3c) SN: S505277 (20x) SN: S5129 (30b)	Cal Date (Certificate No.) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02132) 01-Apr-15 (No. 217-02132) 01-Apr-15 (No. 217-02133)	are part of the certificate. and humidity < 70%. Scheduled Calibration Mar-16 Mar-16 Mar-16 Mar-16 Mar-16 Mar-16
The measurements and the unc All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E44198 Power sensor E4412A Reference 3 dB Attenuator Reference 30 dB Attenuator Reference 30 dB Attenuator	ertainties with confidence pr ucted in the closed laborator RTE critical for calibration) ID GB41293874 MY41498087 SN: 55054 (3c) SN: 55077 (20x) SN: 55129 (30b) SN: 2328	Cal Date (Certificate No.) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02123) 01-Apr-15 (No. 217-02133) 08-Oct-14 (No. ER3-2328_Oct14)	are part of the certificate. and humidity < 70%. Scheduled Calibration Mar-16 Mar-16 Mar-16 Mar-16 Mar-16 Mar-16 Oct-15
The measurements and the unc All calibrations have been condu Calibration Equipment used (M& Primary Standards Power meter E44198 Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference Probe ER3DV6 DAE4	ertainties with confidence pr ucted in the closed laborator ATE critical for calibration) ID GB41293874 MY41498087 SN: S5054 (3c) SN: S5054 (3c) SN: S5277 (20x) SN: S5129 (30b) SN: 2328 SN: 789	Cal Date (Certificate No.) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02129) 01-Apr-15 (No. 217-02132) 01-Apr-15 (No. 217-02133) 08-Oct-14 (No. ER3-2328_Oct14) 16-Mar-15 (No. DAE4-789_Mar15)	are part of the certificate. and humidity < 70%. Scheduled Calibration Mar-16 Mar-16 Mar-16 Mar-16 Mar-16 Mar-16 Oct-15 Mar-16
The measurements and the unc All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power sensor E4419B Power sensor E4419B Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference Probe ER3DV6 DAE4 Secondary Standards	ertainties with confidence pr ucted in the closed laborator ATE critical for calibration) ID GB41293874 MY41498087 SN: S5054 (3c) SN: S5054 (3c) SN: S5527 (20x) SN: S5129 (30b) SN: 2328 SN: 789 ID	Obability are given on the following pages and y facility: environment temperature (22 ± 3)°C a Cal Date (Certificate No.) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02129) 01-Apr-15 (No. 217-02132) 01-Apr-15 (No. 217-02133) 08-Oct-14 (No. ER3-2328_Oct14) 16-Mar-15 (No. DAE4-769_Mar15) Check Date (in house)	are part of the certificate. and humidity < 70%. Scheduled Calibration Mar-16 Mar-16 Mar-16 Mar-16 Mar-16 Oct-15 Mar-16 Scheduled Check
The measurements and the unc All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E44198 Power sensor E4412A Reference 3 dB Attenuator Reference 3 0 dB Attenuator Reference 20 dB Attenuator Reference Probe ER3DV6 DAE4 Secondary Standards RF generator HP 8648C	ertainties with confidence pr ucted in the closed laborator &TE critical for calibration) ID GB41293874 MY41498087 SN: S5054 (3c) SN: S5054 (3c) SN: S5129 (30b) SN: 2328 SN: 789 ID US3642U01700	Obability are given on the following pages and y facility: environment temperature (22 ± 3)°C a Cal Date (Certificate No.) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02132) 01-Apr-15 (No. 217-02133) 08-Oct-14 (No. ER3-2328_Oct14) 16-Mar-15 (No. DAE4-789_Mar15) Check Date (in house) 4-Aug-99 (in house check Apr-13)	are part of the certificate. and humidity < 70%. Scheduled Calibration Mar-16 Mar-16 Mar-16 Mar-16 Mar-16 Oct-15 Mar-16 Scheduled Check In house check: Apr-16
The measurements and the unc All calibrations have been condu Calibration Equipment used (M8 Primary Standards Power meter E44198 Power sensor E4412A Reference 3 dB Attenuator Reference 3 dB Attenuator Reference 3 dB Attenuator Reference 20 dB Attenuator Reference Probe ER3DV6 DAE4 Secondary Standards RF generator HP 8648C Network Analyzer HP 8753E	ertainties with confidence pr ucted in the closed laborator ATE critical for calibration) ID GB41293874 MY41498087 SN: S5054 (3c) SN: S5129 (30b) SN: 2328 SN: 789 ID US3642U01700 US37390585 Name	Cal Date (Certificate No.) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02128) 01-Apr-15 (No. 217-02129) 01-Apr-15 (No. 217-02129) 01-Apr-15 (No. 217-02132) 01-Apr-15 (No. 217-02132) 01-Apr-15 (No. 217-02132) 01-Apr-15 (No. 217-02132) 01-Apr-15 (No. 217-02133) 08-Oct-14 (No. ER3-2328_Oct14) 16-Mar-15 (No. DAE4-769_Mar15) Check Date (in house) 4-Aug-99 (in house check Apr-13) 18-Oct-01 (in house check Oct-14) Function	are part of the certificate. and humidity < 70%. Scheduled Calibration Mar-16 Mar-16 Mar-16 Mar-16 Mar-16 Oct-15 Mar-16 Oct-15 Mar-16 Scheduled Check In house check: Oct-15

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Accreditation No.: SCS 0108

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Glossary:	
NORMx,y,z	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization ϕ	φ rotation around probe axis
Polarization 9	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center),
	i.e., θ = 0 is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
- b) CTIA Test Plan for Hearing Aid Compatibility, Rev 3.0, November 2013

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization θ = 0 for XY sensors and θ = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

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ER3DV6 - SN:2335

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August 24, 2015

Probe ER3DV6

SN:2335

Manufactured: Calibrated: September 9, 2003 August 24, 2015

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Calibrated for DASY/EASY Systems (Note: non-compatible with DASY2 system!)

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DASY/EASY - Parameters of Probe: ER3DV6 - SN:2335

Basic Calibration Parameters

ER3DV6 - SN:2335

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm $(\mu V/(V/m)^2)$	1.65	1.67	1.88	± 10.1 %
DCP (mV) ^B	100.3	99.3	100.2	

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Modulation Calibration Parameters

UID	Communication System Name		A dB	B dB√μV	с	D dB	VR mV	Unc ^E (k=2)
0	CW	X	0.0	0.0	1.0	0.00	203.0	±3.3 %
		Y	0.0	0.0	1.0		160.6	
		Z	0.0	0.0	1.0		203.5	

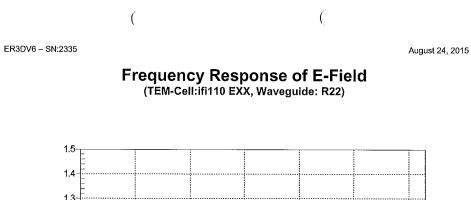
The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

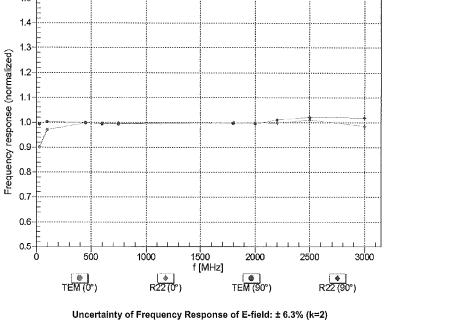
^B Numerical linearization parameter: uncertainty not required.
^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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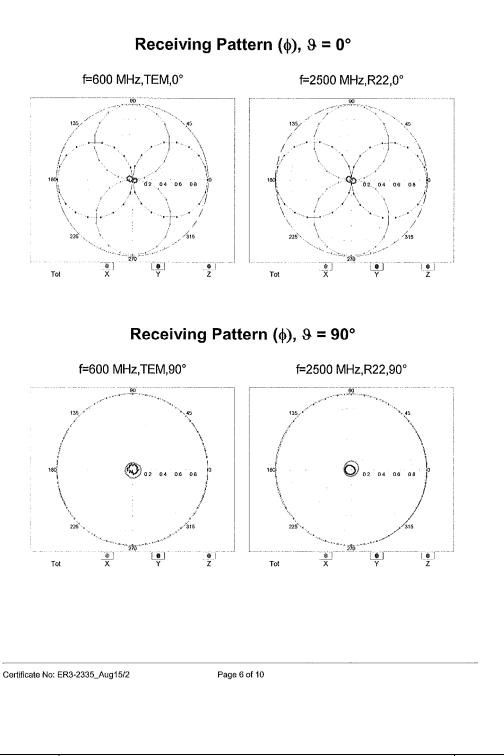
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ER3DV6 - SN:2335

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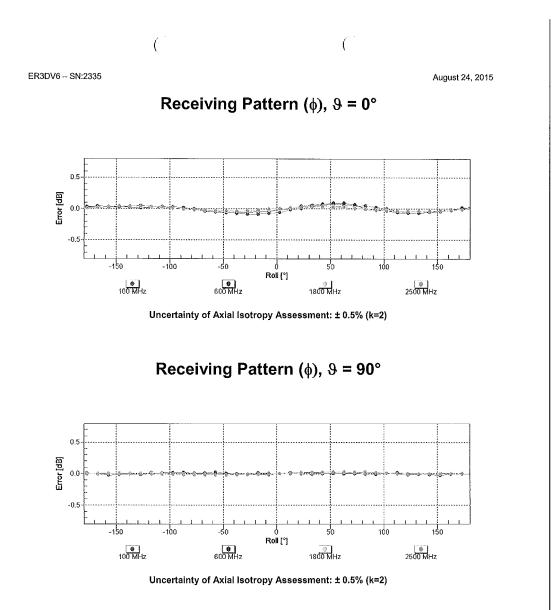
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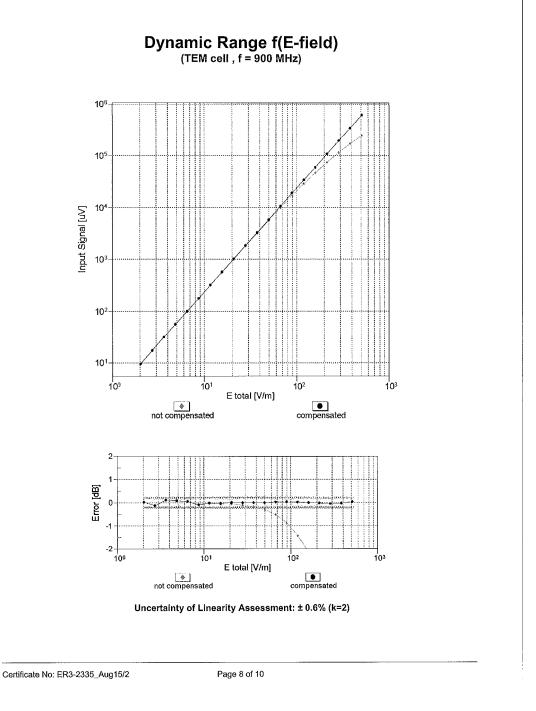
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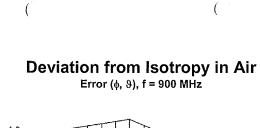
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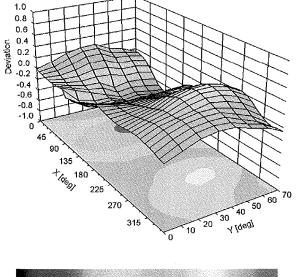


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Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

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DASY/EASY - Parameters of Probe: ER3DV6 - SN:2335

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Other Probe Parameters

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Sensor Arrangement	Rectangular
Connector Angle (°)	82.7
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

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Client PC Test

Certificate No: CD835V3-1082_May16

Accreditation No.: SCS 0108

CALIBRATION (CERTIFICAT	E	
Object	CD835V3 - SN:	1082	
Calibration procedure(s)	QA CAL-20.v6 Calibration proce	edure for dipoles in air	ăA
Calibration date:	May 10, 2016		05/15/2016
The measurements and the unce	rtainties with confidence p	ional standards, which realize the physical uni robability are given on the following pages an ry facility: environment temperature (22 \pm 3)°C	d are part of the certificate.
Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	06-Apr-16 (No. 217-02288/02289)	Apr-17
Power sensor NRP-Z91	SN: 103244	06-Apr-16 (No. 217-02288)	Apr-17
Power sensor NRP-Z91	SN: 103245	06-Apr-16 (No. 217-02289)	Apr-17
Reference 20 dB Attenuator	SN: 5058 (20k)	05-Apr-16 (No. 217-02292)	Apr-17 Apr-17
Type-N mismatch combination	SN: 5047.2 / 06327	05-Apr-16 (No. 217-02295)	
Probe ER3DV6	SN: 2336	31-Dec-15 (No. ER3-2336 Dec15)	Apr-17 Dec-16
Probe H3DV6	SN: 6065	31-Dec-15 (No. H3-6065_Dec15)	Dec-16
DAE4	SN: 781	04-Sep-15 (No. DAE4-781_Sep15)	Sep-16
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Sep-14)	In house check: Oct-17
Power sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Sep-14)	In house check: Oct-17
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Sep-14)	In house check: Oct-17
RF generator R&S SMT-06	SN: 832283/011	27-Aug-12 (in house check Oct-15)	In house check: Oct-17
Network Analyzer HP 8753E	SN: US37390585	18-Oct-01 (in house check Oct-15)	In house check: Oct-16
0	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	deh
Approved by:	Katja Pokovic	Technical Manager	Solly
This calibration certificate shall no	ot be reproduced except in	full without written approval of the laboratory.	Issued: May 12, 2016

Certificate No: CD835V3-1082_May16

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Reviewed by: PCTEST FCC ID: ZNFH918 HAC (RF EMISSIONS) TEST REPORT 🕑 LG Quality Manager Filename: Test Dates: DUT Type: Page 55 of 72 0Y1608121392.ZNF 08/08/2016 - 08/10/2016 Portable Handset © 2016 PCTEST Engineering Laboratory, Inc. **REV 3.1.M**

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Accreditation No.: SCS 0108

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References

ANSI-C63.19-2011 [1]

American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 835 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	107.5 V/m = 40.63 dBV/m
Maximum measured above low end	100 mW input power	106.1 V/m = 40.51 dBV/m
Averaged maximum above arm	100 mW input power	106.8 V/m ± 12.8 % (k=2)

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance	
800 MHz	16.4 dB	44.5 Ω - 13.4 jΩ	
835 MHz	26.3 dB	50.0 Ω + 4.9 ϳΩ	
900 MHz	16.4 dB	57.4 Ω - 14.7 jΩ	
950 MHz	21.9 dB	43.6 Ω + 4.0 ϳΩ	
960 MHz	17.2 dB	47.9 Ω + 13.5 jΩ	

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

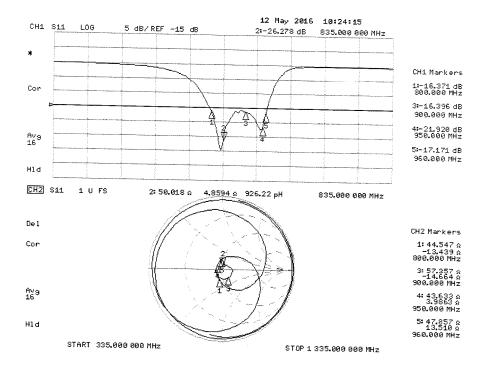
After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot



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DASY5 E-field Result

Date: 10.05.2016

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1082

Communication System: UID 0 - CW; Frequency: 835 MHz Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

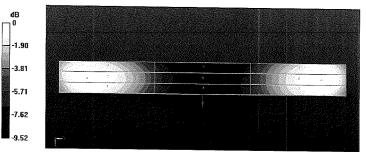
DASY52 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2015;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 04.09.2015
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7372)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid Compatibility Test (41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 109.8 V/m; Power Drift = 0.02 dB Applied MIF = 0.00 dB RF audio interference level = 40.63 dBV/m Emission category: M3

MIF scaled E-field

		Grid 3 M3
40.52 dBV/m	40.63 dBV/m	40.46 dBV/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
35.69 dBV/m	35.78 dBV/m	35.62 dBV/m
Grid 7 M3	Grid 8 M3	Grid 9 M3
40.38 dBV/m	40.51 dBV/m	40.37 dBV/m



0 dB = 107.5 V/m = 40.63 dBV/m

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Client PC Test		Certifi	cate No: CD1880V3-1064_May16
CALIBRATION	CERTIFICAT	E	
Object	CD1880V3 - SN	: 1064	
Calibration procedure(s)	QA CAL-20.v6 Calibration procedure for dipoles in air		25/25/2016
Calibration date:	May 12, 2016		
the measurements and the unce	cted in the closed laborato	ional standards, which realize the phy: robability are given on the following p ry facility: environment temperature (2	ages and are part of the certificate.
Primary Standards	ID#	Cal Date (Certificate No.)	
Power meter NRP	SN: 104778	06-Apr-16 (No. 217-02288/02289)	Scheduled Calibration
Power sensor NRP-Z91	SN: 103244	06-Apr-16 (No. 217-02288)	Apr-17
Power sensor NRP-Z91	SN: 103245	06-Apr-16 (No. 217-02289)	Apr-17
Reference 20 dB Attenuator	SN: 5058 (20k)	05-Apr-16 (No. 217-02292)	Apr-17
Type-N mismatch combination	SN: 5047.2 / 06327	05-Apr-16 (No. 217-02295)	Apr-17
Probe ER3DV6	SN: 2336	31-Dec-15 (No. ER3-2336, Dec15)	Apr-17
Probe H3DV6	SN: 6065	31-Dec-15 (No. H3-6065_Dec15)	±00 i0
DAE4	SN: 781	04-Sep-15 (No. DAE4-781_Sep15)	Dec-16 Sep-16
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Sep-14)	
Power sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Sep-14	
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Sep-14	
RF generator R&S SMT-06	SN: 832283/011	27-Aug-12 (in house check Oct-15)	
Network Analyzer HP 8753E	SN: US37390585	18-Oct-01 (in house check Oct-15)	In house check: Oct-16
Caliburate d to a	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	J=VC-
Approved by:	Katja Pokovic	Technical Manager	' flitte
This calibration certificate shall no	t be reproduced except in	full without written approval of the lab	Issued: May 12, 2016 pratory.

Certificate No: CD1880V3-1064_May16

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Reviewed by: PCTEST FCC ID: ZNFH918 HAC (RF EMISSIONS) TEST REPORT 🕞 LG Quality Manager Filename: Test Dates: DUT Type: Page 60 of 72 0Y1608121392.ZNF 08/08/2016 - 08/10/2016 Portable Handset © 2016 PCTEST Engineering Laboratory, Inc. **REV 3.1.M**

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Accreditation No.: SCS 0108

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References

[1] ANSI-C63.19-2011

American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the diclectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.8
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1730 MHz ± 1 MHz 1880 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 1730 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum	
Maximum measured above high end	100 mW input power	96.1 V/m = 39.66 dBV/m	
Maximum measured above low end	100 mW input power	95.3 V/m = 39.58 dBV/m	
Averaged maximum above arm	100 mW input power	95.7 V/m ± 12.8 % (k=2)	

Maximum Field values at 1880 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum	
Maximum measured above high end	100 mW input power	91.2 V/m = 39.20 dBV/m	
Maximum measured above low end	100 mW input power	88.0 V/m = 38.89 dBV/m	
Averaged maximum above arm	100 mW input power	89.6 V/m ± 12.8 % (k=2)	

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Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Nominal Frequencies

Frequency	Return Loss	Impedance	
1730 MHz	24.0 dB	49.6 Ω + 6.3 jΩ	
1880 MHz	19.8 dB	49.5 Ω + 10.2 jΩ	
1900 MHz	20.4 dB	52.9 Ω + 9.4 jΩ	
1950 MHz	26.8 dB	54.4 Ω + 1.8 jΩ	
2000 MHz	22.7 dB	43.2 Ω + 0.8 jΩ	

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

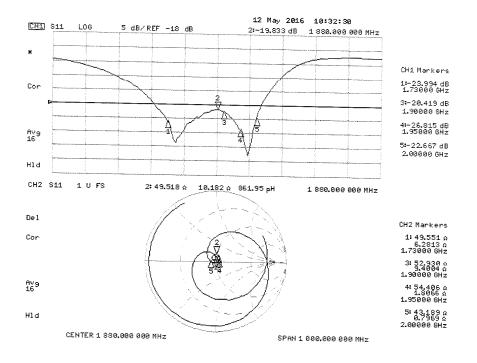
After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot



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DASY5 E-field Result

Date: 10.05.2016

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1064

Communication System: UID 0 - CW ; Frequency: 1880 MHz, Frequency: 1730 MHz Medium parameters used: $\sigma=0$ S/m, $\epsilon_r=1;\,\rho=1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 31.12.2015; .
- Sensor-Surface: (Fix Surface) ٠
- Electronics: DAE4 Sn781; Calibrated: 04.09.2015
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070 .
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7372)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm Reference Value = 151.7 V/m; Power Drift = -0.01 dB Applied MIF = 0.00 dBRF audio interference level = 39.20 dBV/m

Emission category: M2

MIF scaled E-field

Grid 1 M2 39.04 dBV/m		Grid 3 M2 39.08 dBV/m
		Grid 6 M2 36.75 dBV/m
	Grid 8 M2 38.89 dBV/m	Grid 9 M2 38.8 dBV/m

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Dipole E-Field measurement @ 1880MHz/E-Scan - 1730MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 168.3 V/m; Power Drift = 0.00 dB Applied MIF = 0.00 dB RF audio interference level = 39.66 dBV/m Emission category: M2

 MIF scaled E-field

 Grid 1 M2
 Grid 2 M2
 Grid 3 M2

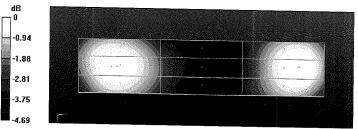
 39.43 dBV/m
 39.58 dBV/m
 39.44 dBV/m

 Grid 4 M2
 Grid 5 M2
 Grid 6 M2

 37.46 dBV/m
 37.56 dBV/m
 37.42 dBV/m

 Grid 7 M2
 Grid 8 M2
 Grid 9 M2

 39.44 dBV/m
 39.66 dBV/m
 39.57 dBV/m



0 dB = 91.23 V/m = 39.20 dBV/m

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15. CONCLUSION

The measurements indicate that the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

Please note that the M-rating for this equipment only represents the field interference possible against a hypothetical and typical hearing aid. The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

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